



# RF Exposure Evaluation Declaration

Product Name : 3D Active Glasses

Model No. : 3DG-001-SDC

FCC ID : P2U3DG001SDC

IC : 10555A-3DG001SDC

Applicant : Samsung Display co., Ltd.

Address : 95, Samsung2-ro, Giheung-gu, Yong-in-si,  
Gyeonggi-do, Korea

Date of Receipt : 07/11/2012

Issued Date : 13/11/2012

Report No. : 12BS021R-RF-US-P20V01

Report Version : V1.0

The test results relate only to the samples tested.

The test results shown in the test report are traceable to the national/international standard through the calibration of the equipment and evaluated measurement uncertainty herein.

This report must not be used to claim product endorsement by TAF, CNAS or any agency of the Government.

The test report shall not be reproduced except in full without the written approval of QuieTek Corporation.

## Test Report Certification

Issued Date : 13/11/2012

Report No. : 12BS021R-RF-US-P20V01

**QuieTek**

Product Name : 3D Active Glasses  
Applicant : Samsung Display co., Ltd.  
Address : 95, Samsung2-ro, Giheung-gu, Yong-in-si, Gyeonggi-do, Korea  
Manufacturer : Samsung Display co., Ltd.  
Address : 95, Samsung2-ro, Giheung-gu, Yong-in-si, Gyeonggi-do, Korea  
Model No. : 3DG-001-SDC  
FCC ID : P2U3DG001SDC  
IC : 10555A-3DG001SDC  
EUT Voltage : DC 3V  
Brand Name : SAMSUNG  
Applicable Standard : FCC OET 65  
RSS-102: Issue 4, March, 2010  
Test Result : Complied  
Performed Location : Suzhou EMC Laboratory  
No.99 Hongye Rd., Suzhou Industrial Park Loufeng  
Hi-Tech Development Zone., Suzhou, China  
TEL: +86-512-6251-5088 / FAX: +86-512-6251-5098  
FCC Registration Number: 800392; IC Lab Code: 4075B

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(Manager: Marlin Chen)

## Laboratory Information

We, **QuieTek Corporation**, are an independent EMC and safety consultancy that was established the whole facility in our laboratories. The test facility has been accredited/accepted(audited or listed) by the following related bodies in compliance with ISO 17025, EN 45001 and specified testing scope:

Taiwan R.O.C.	:	BSMI, NCC, TAF
Germany	:	TUV Rheinland
Norway	:	Nemko, DNV
USA	:	FCC, NVLAP
Japan	:	VCCI
China	:	CNAS

The related certificate for our laboratories about the test site and management system can be downloaded from QuieTek Corporation's Web Site :<http://www.quietek.com/tw/ctg/cts/accreditations.htm>  
The address and introduction of QuieTek Corporation's laboratories can be founded in our Web site :  
<http://www.quietek.com/>

If you have any comments, Please don't hesitate to contact us. Our contact information is as below:

## **HsinChu Testing Laboratory :**

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## **LinKou Testing Laboratory :**

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Suzhou Testing Laboratory

No.99 Hongye Rd., Suzhou Industrial Park Loufeng Hi-Tech Development Zone., SuZhou, China  
TEL : +86-512-6251-5088 / FAX : 86-512-6251-5098 E-Mail : [service@quietek.com](mailto:service@quietek.com)

## 1. RF Exposure Evaluation

### 1.1. Limits

According to FCC 1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in 1.1307(b)

#### LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency Range (MHz)	Electric Field Strength (V/m)	Magnetic Field Strength (A/m)	Power Density (mW/cm <sup>2</sup> )	Average Time (Minutes)
<b>(A) Limits for Occupational/ Control Exposures</b>				
300-1500	--	--	F/300	6
1500-100,000	--	--	5	6
<b>(B) Limits for General Population/ Uncontrolled Exposures</b>				
300-1500	--	--	F/1500	6
1500-100,000	--	--	1	30

F= Frequency in MHz

Friis Formula

Friis transmission formula:  $P_d = (P_{out} \cdot G) / (4 \cdot \pi \cdot r^2)$

Where

$P_d$  = power density in mW/cm<sup>2</sup>

$P_{out}$  = output power to antenna in mW

$G$  = gain of antenna in linear scale

$\pi$  = 3.1416

$r$  = distance between observation point and center of the radiator in cm

$P_d$  is the limit of MPE, 1 mW/cm<sup>2</sup>. If we know the maximum gain of the antenna and the total power input to the antenna, through the calculation, we will know the distance  $r$  where the MPE limit is reached.

## 1.2. Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.

The temperature and related humidity: 18°C and 78% RH.

## 1.3. Test Result of RF Exposure Evaluation

Product	:	3D Active Glasses
Test Item	:	RF Exposure Evaluation
Test Site	:	AC-6

### Antenna Gain:

Antenna Gain: The maximum Gain measured in fully anechoic chamber is 2.61dBi in logarithm scale.

### Output Power into Antenna & RF Exposure Evaluation Distance:

Frequency Band (MHz)	Maximum Output Power to Antenna (mW)	Power Density at R = 20 cm (mW/cm <sup>2</sup> )
2402 - 2480	0.4227	0.000153

### Note:

The power density Pd (4th column) at a distance of 20 cm calculated from the Friis transmission formula is far below the limit of 1 mW/cm<sup>2</sup>.